

Search Notes

Application/Control No.

09/853,318

Examiner

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Applicant(s)/Patent under
Reexamination

HOSHIDA, TAKESHI

Art Unit

2633

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST text search (see search history)	1/17/2005	cl
IEEE database search (search terms included optical FSK/FM, FDM/WDM, spectral efficiency, channel spacing/separation)	1/17/2005	cl